

Notice of References Cited	Application/Control No. 09/840,023	Applicant(s)/Patent Under Reexamination LEE, SUNG LYONG	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6519283	02-2003	Cheney et al.	375/240.01
	C	US-6460030	10-2002	Ludtke	707/3
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NON-PATENT DOCUMENTS

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